

SLOVENSKI STANDARD SIST EN ISO 17526:2003

01-november-2003

Cdhj_Ujb'cdhj bj'jbghfi a Ybhj'!'@JgYf /j'jb'`UgYfg_UcdfYa UËbjj`^Yb/g_UXcVU `UgYf^Yj`fl+GC`%+)&*.&\$\$'Ł

Optics and optical instruments - Lasers and laser-related equipment - Lifetime of lasers (ISO 17526:2003)

Optik und optische Instrumente - Laser und Laseranlagen - Lebensdauer von Lasern (ISO 17526:2003) **iTeh STANDARD PREVIEW**

Optique et instruments d'optique - Lasers et équipements associés aux lasers - Durée de vie des lasers (ISO 17526:2003) SIST EN ISO 17526:2003

https://standards.iteh.ai/catalog/standards/sist/29d32b0c-895d-46b9-

Ta slovenski standard je istoveten z: EN ISO 17526-2003

ICS:

31.260 Optoelektronika, laserska oprema

Optoelectronics. Laser equipment

SIST EN ISO 17526:2003

en

SIST EN ISO 17526:2003

iTeh STANDARD PREVIEW (standards.iteh.ai)

SIST EN ISO 17526:2003

EUROPEAN STANDARD NORME EUROPÉENNE EUROPÄISCHE NORM

EN ISO 17526

June 2003

ICS 31.260

English version

Optics and optical instruments - Lasers and laser-related equipment - Lifetime of lasers (ISO 17526:2003)

Optique et instruments d'optique - Lasers et équipements associés aux lasers - Durée de vie des lasers (ISO 17526:2003) Laser und Laseranlagen - Lebensdauer von Lasern (ISO 17526:2003)

This European Standard was approved by CEN on 20 May 2003.

CEN members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration. Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the Management Centre or to any CEN member.

This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CEN member into its own language and notified to the Management Centre has the same status as the official versions.

CEN members are the national standards bodies of Austra, Belgium, Czech Republic, Denmark, Finland, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Luxembourg, Malta, Netherlands, Norway, Portugal, Slovakia, Spain, Sweden, Switzerland and United Kingdom.

SIST EN ISO 17526:2003 https://standards.iteh.ai/catalog/standards/sist/29d32b0c-895d-46b9-9d14-db1f5c26a166/sist-en-iso-17526-2003



EUROPEAN COMMITTEE FOR STANDARDIZATION COMITÉ EUROPÉEN DE NORMALISATION EUROPÄISCHES KOMITEE FÜR NORMUNG

Management Centre: rue de Stassart, 36 B-1050 Brussels

© 2003 CEN All rights of exploitation in any form and by any means reserved worldwide for CEN national Members.

Ref. No. EN ISO 17526:2003 E

EN ISO 17526:2003 (E)

CORRECTED 2003-07-16

Foreword

This document (EN ISO 17526:2003) has been prepared by Technical Committee ISO/TC 176 "Quality management and quality assurance" in collaboration with Technical Committee CEN/TC 123 "Lasers and laser-related equipment", the secretariat of which is held by DIN.

This European Standard shall be given the status of a national standard, either by publication of an identical text or by endorsement, at the latest by December 2003, and conflicting national standards shall be withdrawn at the latest by December 2003.

According to the CEN/CENELEC Internal Regulations, the national standards organizations of the following countries are bound to implement this European Standard: Austria, Belgium, Czech Republic, Denmark, Finland, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Luxembourg, Malta, Netherlands, Norway, Portugal, Slovakia, Spain, Sweden, Switzerland and the United Kingdom.

Endorsement notice

The text of ISO 17526:2003 has been approved by CEN as EN ISO 17526:2003 without any modifications. (standards.iteh.ai)

NOTE Normative references to International Standards are listed in Annex ZA (normative).

EN ISO 17526:2003 (E)

Annex ZA

(normative)

Normative references to international publications with their relevant European publications

This European Standard incorporates by dated or undated reference, provisions from other publications. These normative references are cited at the appropriate places in the text and the publications are listed hereafter. For dated references, subsequent amendments to or revisions of any of these publications apply to this European Standard only when incorporated in it by amendment or revision. For undated references the latest edition of the publication referred to applies (including amendments).

NOTE Where an International Publication has been modified by common modifications, indicated by (mod.), the relevant EN/HD applies.

Publication	Year	Title	<u>EN</u>	Year	
ISO 11145	2001	Optics and optical instruments - Lasers and laser-related equipment - Vocabulary and symbols en STANDARD PREV	EN ISO 11145	2001	
ISO 11554	2003	Optics and optical instruments - Lasers and laser-related equipment Test11) methods for laser beam power, energy and temporal characteristics.2003 /standards.iteh.ai/catalog/standards/sist/29d32b0c-8	EN ISO 11554	2003	
9d14-db1f5c26a166/sist-en-iso-17526-2003					

SIST EN ISO 17526:2003

iTeh STANDARD PREVIEW (standards.iteh.ai)

INTERNATIONAL STANDARD

ISO 17526

First edition 2003-06-15

Optics and optical instruments — Lasers and laser-related equipment — Lifetime of lasers

Optique et instruments d'optique — Lasers et équipements associés aux lasers — Durée de vie des lasers

iTeh STANDARD PREVIEW (standards.iteh.ai)

SIST EN ISO 17526:2003 https://standards.iteh.ai/catalog/standards/sist/29d32b0c-895d-46b9-9d14-db1f5c26a166/sist-en-iso-17526-2003



Reference number ISO 17526:2003(E)

PDF disclaimer

This PDF file may contain embedded typefaces. In accordance with Adobe's licensing policy, this file may be printed or viewed but shall not be edited unless the typefaces which are embedded are licensed to and installed on the computer performing the editing. In downloading this file, parties accept therein the responsibility of not infringing Adobe's licensing policy. The ISO Central Secretariat accepts no liability in this area.

Adobe is a trademark of Adobe Systems Incorporated.

Details of the software products used to create this PDF file can be found in the General Info relative to the file; the PDF-creation parameters were optimized for printing. Every care has been taken to ensure that the file is suitable for use by ISO member bodies. In the unlikely event that a problem relating to it is found, please inform the Central Secretariat at the address given below.

iTeh STANDARD PREVIEW (standards.iteh.ai)

SIST EN ISO 17526:2003 https://standards.iteh.ai/catalog/standards/sist/29d32b0c-895d-46b9-9d14-db1f5c26a166/sist-en-iso-17526-2003

© ISO 2003

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from either ISO at the address below or ISO's member body in the country of the requester.

ISO copyright office Case postale 56 • CH-1211 Geneva 20 Tel. + 41 22 749 01 11 Fax + 41 22 749 09 47 E-mail copyright@iso.org Web www.iso.org Published in Switzerland

Contents

Forev	word	iv
Introd	duction	v
1	Scope	1
2	Normative references	1
3 3.1 3.2 3.3 3.4 3.5	Terms and definitions Modes of operation Operating conditions Lifetime related terms Types and classification Others	
4 4.1 4.2	Symbols and abbreviated terms Symbols Abbreviated terms	6
5 5.1 5.2 5.3 5.4 5.5	Test methods General Selection of lasers for lifetime testing A.R.D. PREVIEW Lifetime test in APPC- and ACC-mode Lifetime test at APC-modestandards.iten.ai Lifetime tests at limited aperture.	6 7 7 7
6 7 Biblic	Evaluation and extrapolation <u>SIST EN ISO 17526:2003</u> https://standards.iteh.ai/catalog/standards/sist/29d32b0c-895d-46b9- Test report9d14-db113c26a166/sist-en-iso-17526-2003 ography	
סוומום	օցլարու	

Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

International Standards are drafted in accordance with the rules given in the ISO/IEC Directives, Part 2.

The main task of technical committees is to prepare International Standards. Draft International Standards adopted by the technical committees are circulated to the member bodies for voting. Publication as an International Standard requires approval by at least 75 % of the member bodies casting a vote.

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO shall not be held responsible for identifying any or all such patent rights.

ISO 17526 was prepared by Technical Committee ISO/TC 172, *Optics and optical instruments*, Subcommittee SC 9, *Electro-optical systems*.

iTeh STANDARD PREVIEW (standards.iteh.ai)

Introduction

There are many different types of lasers with very different attributes and very different areas of application; not all types of lasers can be treated by the same means and measures to characterize and specify their longterm behaviour and lifetime.

This International Standard covers many types of laser, but not all methods and procedures can be applied to all types.

There are lasers, primarily laser diodes in the lower power range, which are produced in large quantities and which allow the performance of lifetime tests on large quantities to gain results on a statistically significant level. In this case and if more than approximately 50 lasers are used for testing, lifetime predictions using informative annex B of IEC 61751:1998, may be applied alternatively to this International Standard.

High-power lasers are manufactured in low quantities and lifetime tests cannot be carried out on statistically significant sample sizes.

There are types of laser of which the main components cannot be repaired, e.g. sealed-tube gas lasers or semiconductor lasers. There are others that can easily be repaired, e.g. CO₂ lasers. The former class may be characterized by "lifetime", the latter more appropriately characterized by "meantime to failure".

iTeh STANDARD PREVIEW (standards.iteh.ai)